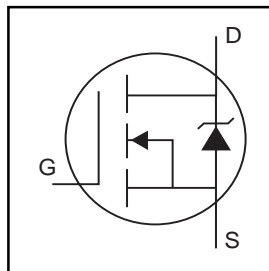




**THE DATASHEET OF
IRL3102STRL**



- Advanced Process Technology
- Surface Mount
- Optimized for 4.5V-7.0V Gate Drive
- Ideal for CPU Core DC-DC Converters
- Fast Switching

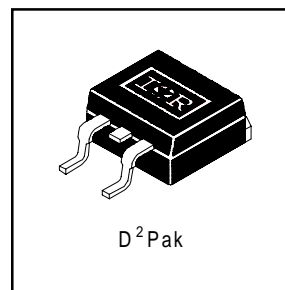


| |
|-----------------------|
| $V_{DSS} = 20V$ |
| $R_{DS(on)} = 0.013W$ |
| $I_D = 61A$ |

Description

These HEXFET Power MOSFETs were designed specifically to meet the demands of CPU core DC-DC converters. Advanced processing techniques combined with an optimized gate oxide design results in a die sized specifically to offer maximum efficiency at minimum cost.

The D²Pak is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The D²Pak is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application.



Absolute Maximum Ratings

| | Parameter | Max. | Units |
|---------------------------|---|--------------|-------|
| $I_D @ T_C = 25^\circ C$ | Continuous Drain Current, $V_{GS} @ 4.5V$ ⑤ | 61 | A |
| $I_D @ T_C = 100^\circ C$ | Continuous Drain Current, $V_{GS} @ 4.5V$ ⑤ | 39 | |
| I_{DM} | Pulsed Drain Current ①⑤ | 240 | |
| $P_D @ T_C = 25^\circ C$ | Power Dissipation | 89 | W |
| | Linear Derating Factor | 0.71 | W/°C |
| V_{GS} | Gate-to-Source Voltage | ± 10 | V |
| E_{AS} | Single Pulse Avalanche Energy②⑤ | 220 | mJ |
| I_{AR} | Avalanche Current① | 35 | A |
| E_{AR} | Repetitive Avalanche Energy① | 8.9 | mJ |
| dv/dt | Peak Diode Recovery dv/dt ③⑤ | 5.0 | V/ns |
| T_J | Operating Junction and | -55 to + 150 | °C |
| T_{STG} | Storage Temperature Range | | |
| | Soldering Temperature, for 10 seconds | | |

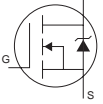
Thermal Resistance

| | Parameter | Typ. | Max. | Units |
|-----------------|---|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case | — | 1.4 | °C/W |
| $R_{\theta JA}$ | Junction-to-Ambient (PCB Mounted,steady-state)** | — | 40 | |

Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|---------------------|--------------------------------------|------|-------|-------|---------------------|--|
| $V_{(BR)DSS}$ | Drain-to-Source Breakdown Voltage | 20 | — | — | V | $V_{GS} = 0V, I_D = 250\mu A$ |
| $dV_{(BR)DSS}/dT_J$ | Breakdown Voltage Temp. Coefficient | — | 0.016 | — | V/ $^\circ\text{C}$ | Reference to $25^\circ\text{C}, I_D = 1\text{mA}$ ⑤ |
| $R_{DS(on)}$ | Static Drain-to-Source On-Resistance | — | — | 0.015 | m | $V_{GS} = 4.5V, I_D = 37A$ ④ |
| | | — | — | 0.013 | | $V_{GS} = 7.0V, I_D = 37A$ ④ |
| $V_{GS(th)}$ | Gate Threshold Voltage | 0.70 | — | — | V | $V_{DS} = V_{GS}, I_D = 250\mu A$ |
| g_{fs} | Forward Transconductance | 36 | — | — | S | $V_{DS} = 16V, I_D = 35A$ ⑤ |
| I_{DSS} | Drain-to-Source Leakage Current | — | — | 25 | μA | $V_{DS} = 20V, V_{GS} = 0V$ |
| | | — | — | 250 | | $V_{DS} = 10V, V_{GS} = 0V, T_J = 150^\circ\text{C}$ |
| I_{GSS} | Gate-to-Source Forward Leakage | — | — | 100 | nA | $V_{GS} = 10V$ |
| | Gate-to-Source Reverse Leakage | — | — | -100 | | $V_{GS} = -10V$ |
| Q_g | Total Gate Charge | — | — | 58 | nC | $I_D = 35A$ |
| Q_{gs} | Gate-to-Source Charge | — | — | 14 | | $V_{DS} = 16V$ |
| Q_{gd} | Gate-to-Drain ("Miller") Charge | — | — | 21 | | $V_{GS} = 4.5V$, See Fig. 6 ④ ⑤ |
| $t_{d(on)}$ | Turn-On Delay Time | — | 10 | — | ns | $V_{DD} = 10V$ |
| t_r | Rise Time | — | 130 | — | | $I_D = 35A$ |
| $t_{d(off)}$ | Turn-Off Delay Time | — | 80 | — | | $R_G = 9.0\Omega, V_{GS} = 4.5V$ |
| t_f | Fall Time | — | 110 | — | | $R_D = 0.28\Omega$, ④ ⑤ |
| L_S | Internal Source Inductance | — | 7.5 | — | nH | Between lead, and center of die contact |
| C_{iss} | Input Capacitance | — | 2500 | — | pF | $V_{GS} = 0V$ |
| C_{oss} | Output Capacitance | — | 1000 | — | | $V_{DS} = 15V$ |
| C_{rss} | Reverse Transfer Capacitance | — | 360 | — | | $f = 1.0\text{MHz}$, See Fig. 5 |

Source-Drain Ratings and Characteristics

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|----------|--|---|------|------|-------|--|
| I_S | Continuous Source Current (Body Diode) | — | — | 61 | A | MOSFET symbol showing the integral reverse p-n junction diode.  |
| I_{SM} | Pulsed Source Current (Body Diode) ① ⑤ | — | — | 240 | | |
| V_{SD} | Diode Forward Voltage | — | — | 1.3 | V | $T_J = 25^\circ\text{C}, I_S = 37A, V_{GS} = 0V$ ④ |
| t_{rr} | Reverse Recovery Time | — | 59 | 88 | ns | $T_J = 25^\circ\text{C}, I_F = 35A$ |
| Q_{rr} | Reverse Recovery Charge | — | 110 | 160 | nC | $di/dt = 100A/\mu s$ ④ ⑤ |
| t_{on} | Forward Turn-On Time | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$) | | | | |

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting $T_J = 25^\circ\text{C}$, $L = 0.36\text{mH}$
 $R_G = 25\Omega, I_{AS} = 35A$.
- ③ $I_{SD} \leq 35A, di/dt \leq 100A/\mu s, V_{DD} \leq V_{(BR)DSS}, T_J \leq 150^\circ\text{C}$
- ④ Pulse width $\leq 300\mu s$; duty cycle $\leq 2\%$.
- ⑤ Uses IRL3102 data and test conditions

** When mounted on FR-4 board using minimum recommended footprint.

For recommended footprint and soldering techniques refer to application note #AN-994.

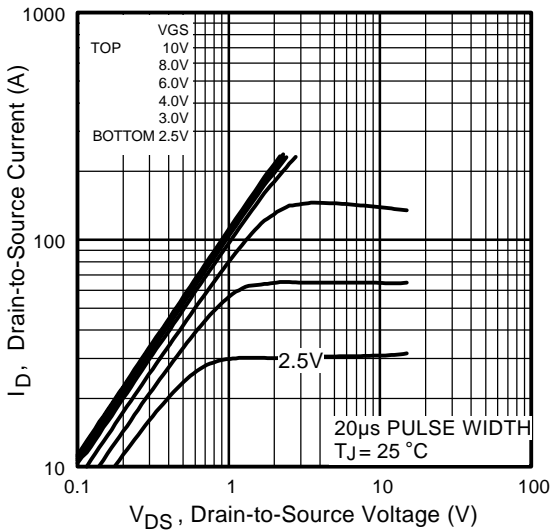


Fig 1. Typical Output Characteristics

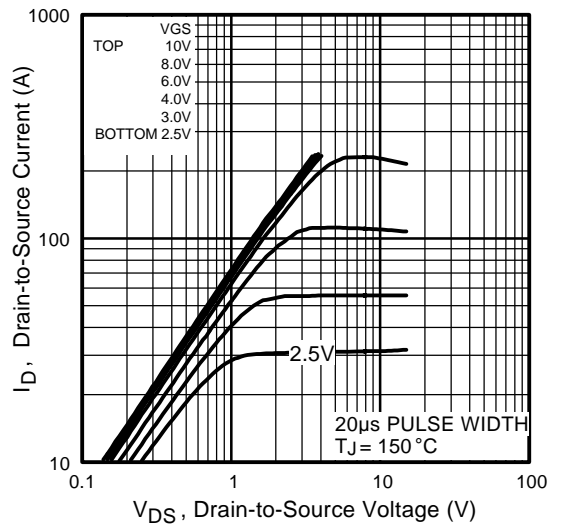


Fig 2. Typical Output Characteristics

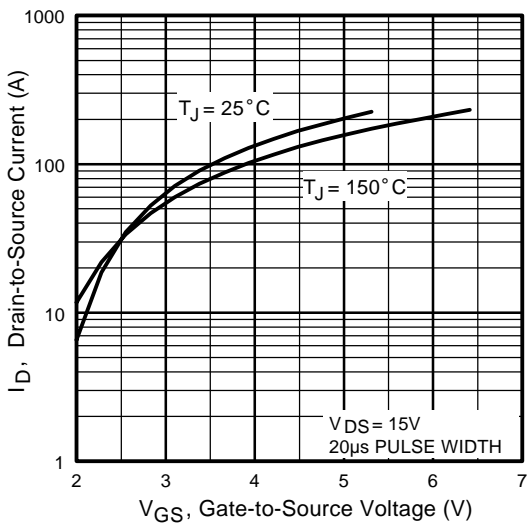


Fig 3. Typical Transfer Characteristics

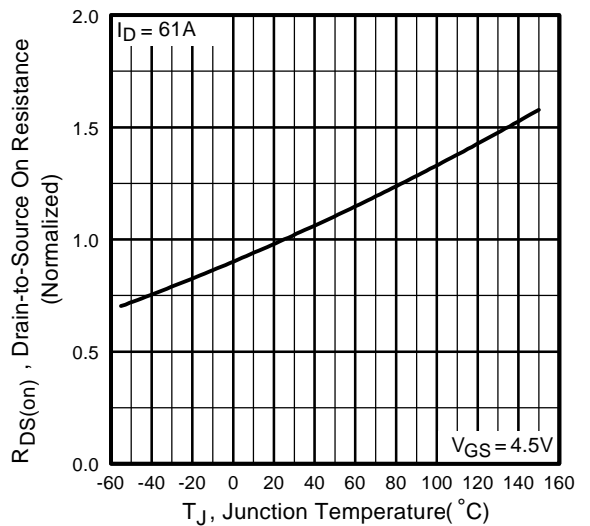


Fig 4. Normalized On-Resistance Vs. Temperature

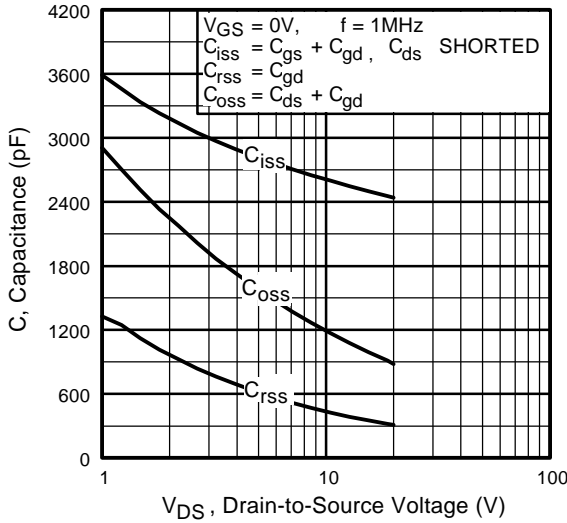


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

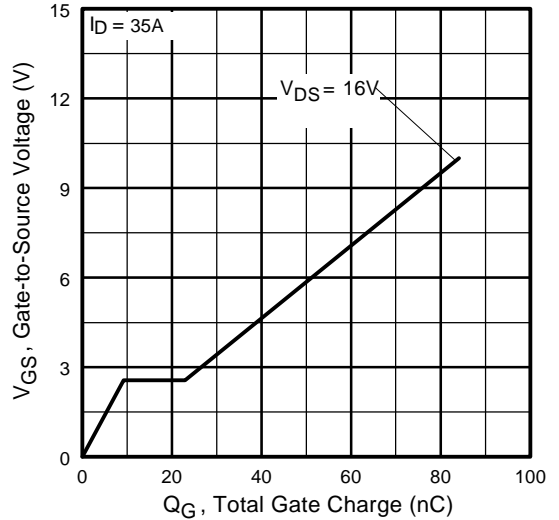


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

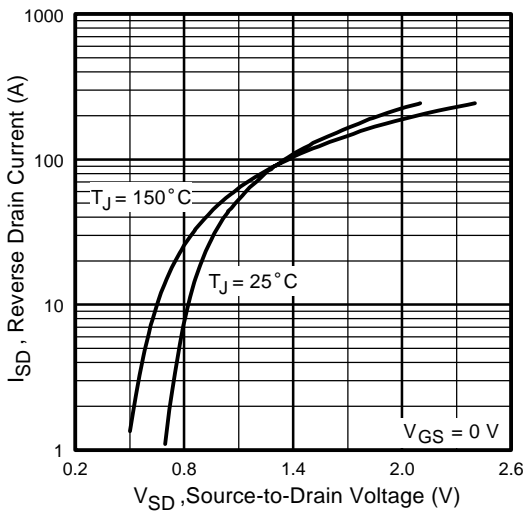


Fig 7. Typical Source-Drain Diode Forward Voltage

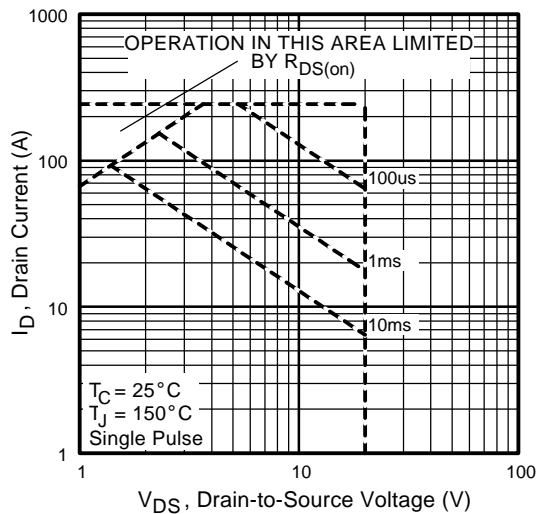


Fig 8. Maximum Safe Operating Area

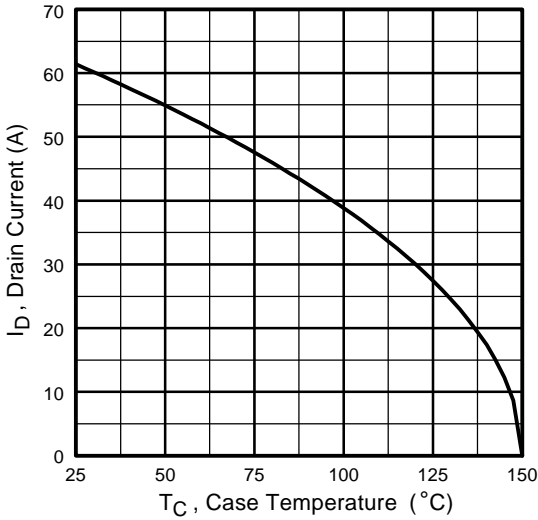


Fig 9. Maximum Drain Current Vs. Case Temperature

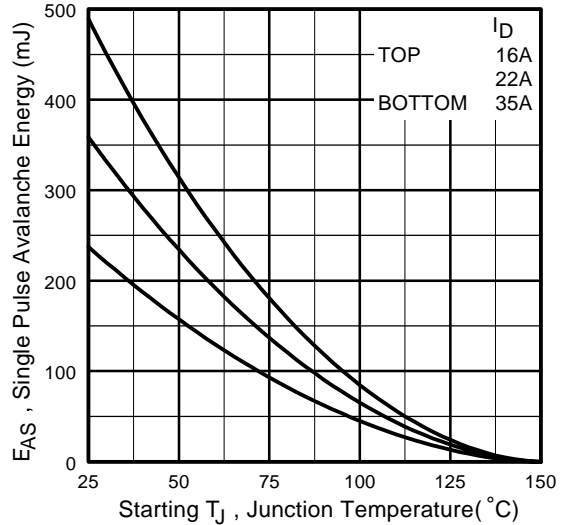


Fig 10. Maximum Avalanche Energy Vs. Drain Current

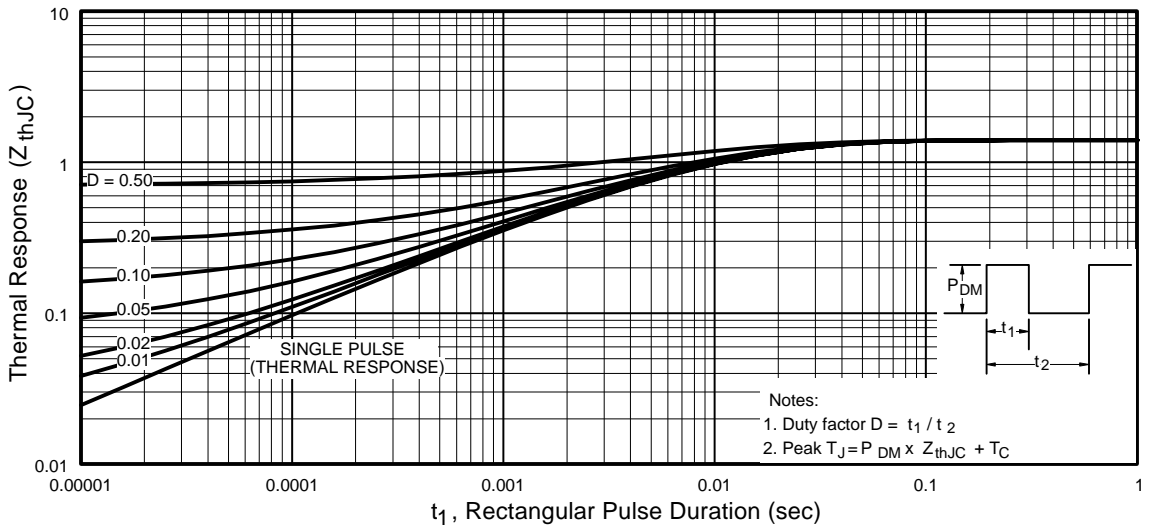


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

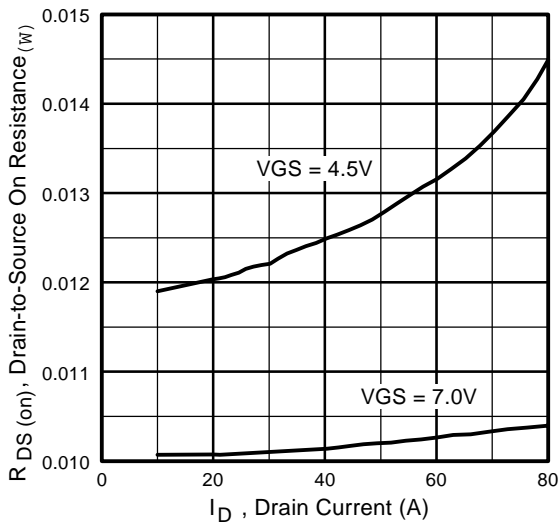


Fig 12. On-Resistance Vs. Drain Current

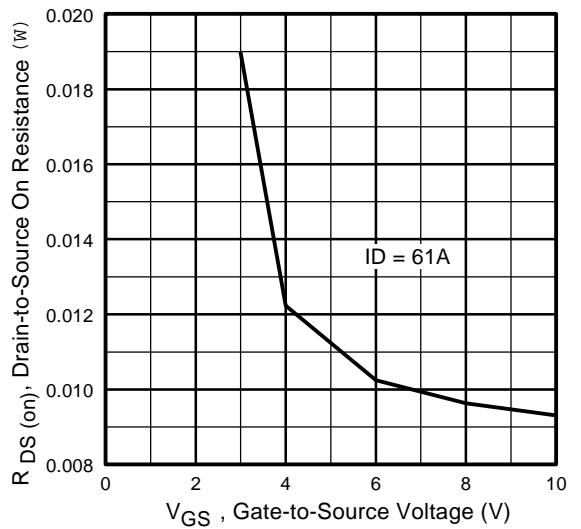
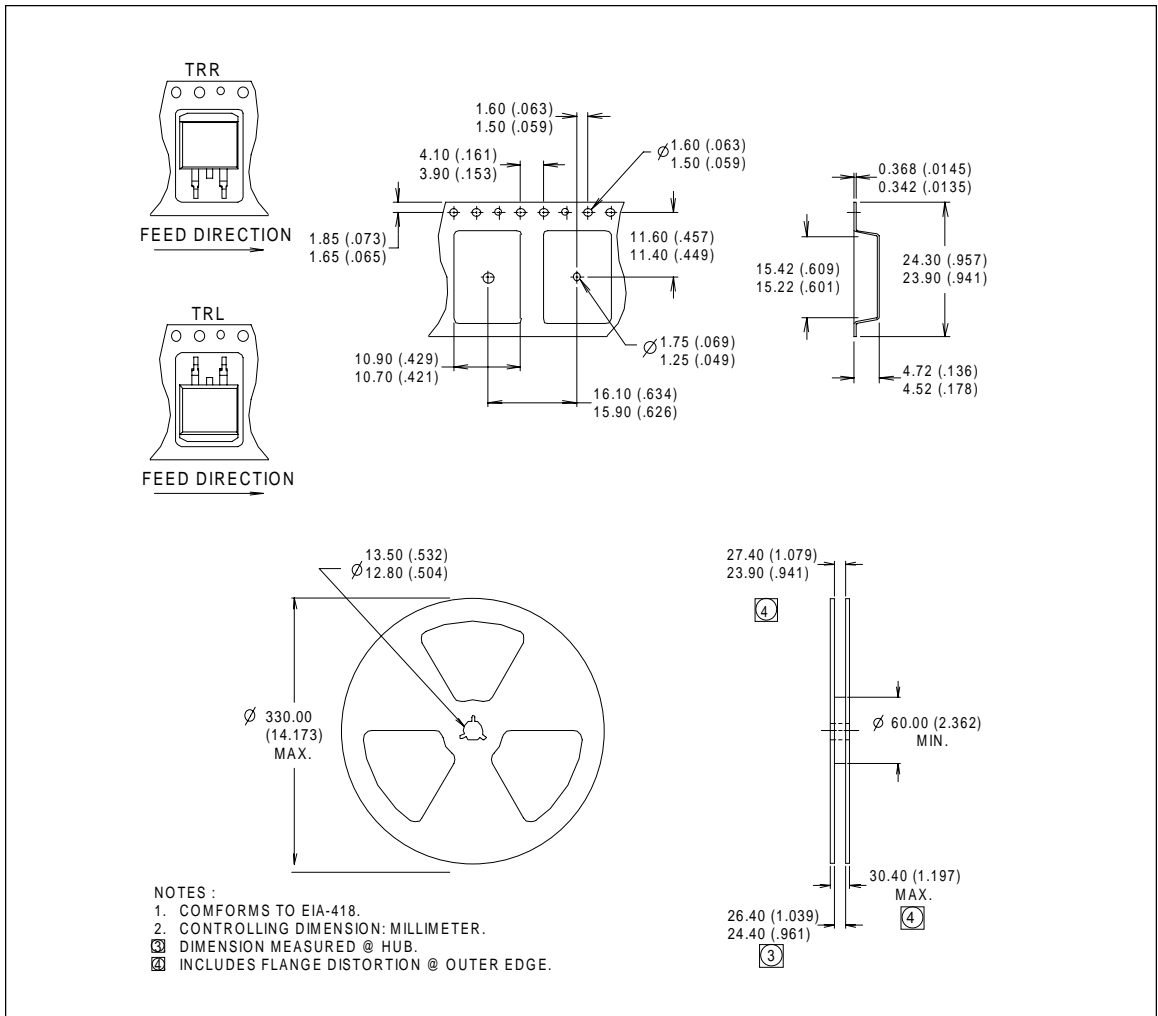


Fig 13. On-Resistance Vs. Gate Voltage

IRL3102S

Tape & Reel Information

D²Pak



WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, Tel: (310) 322 3331

EUROPEAN HEADQUARTERS: Hurst Green, Oxted, Surrey RH8 9BB, UK Tel: ++ 44 1883 732020

IR CANADA: 7321 Victoria Park Ave., Suite 201, Markham, Ontario L3R 2Z8, Tel: (905) 475 1897

IR GERMANY: Saalburgstrasse 157, 61350 Bad Homburg Tel: ++ 49 6172 96590

IR ITALY: Via Liguria 49, 10071 Borgaro, Torino Tel: ++ 39 11 451 0111

IR FAR EAST: K&H Bldg., 2F, 30-4 Nishi-Ikebukuro 3-Chome, Toshima-Ku, Tokyo Japan 171 Tel: 81 3 3983 0086

IR SOUTHEAST ASIA: 315 Outram Road, #10-02 Tan Boon Liat Building, Singapore 0316 Tel: 65 221 8371

<http://www.irf.com/> Data and specifications subject to change without notice. 9/97

Note: For the most current drawings please refer to the IR website at:
<http://www.irf.com/package/>

Looking for pricing, stock, or lifecycle information?

Click below to explore more details on WIN SOURCE:

- ⊖ [View IRL3102STRL on WIN SOURCE](#)
- ⊖ [Infineon Technologies](#) Information

Optimize Your Supply Chain with WIN SOURCE Solutions

- ✓ Global Sourcing Solution
- ✓ Obsolete Management
- ✓ Cost Control Management
- ✓ Shortage Management
- ✓ Alternative Solution
- ✓ Excess Inventory Management